

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10541746	BABA ET AL.
	Examiner Pepitone, Michael	Art Unit 1796

SEARCHED

Class	Subclass	Date	Examiner
523	106, 107	1/11/08	MFP
523	106, 107, 108	7/21/2008	MFP
351	160h, 160r	3/12/2009	MFP
524	264, 258	3/12/2009	MFP
523	108	10/21/2009	MFP
351	160r	10/21/2009	MFP
523	106, 107, 108	2/26/2010	MFP
351	160h	2/26/2010	MFP
523	106	8/25/2010	MFP

SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	1/11/08	MFP
inventor name search, PALM	1/11/08	MFP
STN structure search	1/11/08	MFP
updated EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	7/21/2008	MFP
updated inventor name search, PALM	7/21/2008	MFP
updated EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	3/12/2009	MFP
updated inventor name search, PALM	3/12/2009	MFP
updated EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	10/21/2009	MFP
updated inventor name search, PALM	10/21/2009	MFP
updated EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	2/26/2010	MFP
updated inventor name search, PALM	2/26/2010	MFP
updated EAST (US-PGPUB, USPAT, EPO, JPO, FPRS, DERWENT) (see attached print out)	8/25/2010	MFP
updated inventor name search, PALM	8/25/2010	MFP

INTERFERENCE SEARCH

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